Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/611,625	JAYASEKARA, WIPUL
Examiner	Art Unit

3729

Paul D. Kim

SEARCHED					
Class	Subclass	Date	Examiner		
29	603.08 603.11 603.13- 603.16	11/21/2005	PK		
	603.18				
360	324.2 324.12	11/21/2005	PK		
	121 122 126	<b>\</b>			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Reviewed Parent Application 09/848,674 US PAT. 6,833,982	11/21/2005	PK	
Text Search EAST/NPL (IEEE)	11/22/2005	PK	